Determination of N and O Atom Density in Ar-N₂-H₂ and Ar-O₂-H₂ Flowing Microwave Post Discharges

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Abstract. — Number densities of N and O atoms have been determined using NO titration in Ar-N₂, Ar-N₂-H₂, Ar-O₂ and Ar-O₂-H₂ flowing microwave (2 450 MHz) post-discharges at 300 and 1500 Pa. The NO titration scheme is discussed from a kinetics point of view and applied to the high dilution of molecular gases in argon. The N/N₂ density ratio is enhanced by a factor 3 when small quantities of H₂ are introduced in Ar-N₂ discharges. The high O/O₂ density ratio obtained in Ar-O₂ post-discharges (0.5 to 0.6) are probably due to adsorbed H₂O that inhibits surface recombination of O-atom. The effect of H₂ addition in Ar-O₂ microwave discharge at 1500 Pa is to decrease the O atom density by homogeneous reaction involving H atoms and OH radicals.

1. Introduction

Flowing microwave post-discharges of reactive gases are studied for surface treatments without charged particles (electrons, ions) interactions. Such remote plasma processes have been performed in microelectronics to obtain Si₃N₄ and SiO₂ thin films [1,2] and in polymer treatments to increase the surface adhesion [3,4]. A flowing microwave post-discharge with N₂ and Ar-N₂ gas mixtures has been previously studied at high gas pressure ($5 \times 10^3 - 6.5 \times 10^4$ Pa) for steel surface nitriding [5]. The thickness and nitrogen content of γ' and ϵ iron nitride layers have been found to increase when a few H₂ was introduced into N₂ (Ar-N₂) to remove thin iron native oxide layers [6].

In the present work, the N atom density has been first determined by NO titration in Ar-N₂ and Ar-N₂-H₂ gas mixtures. Then, the O atom density has been deduced in Ar-O₂ and in Ar-O₂-H₂ gas mixtures by introducing NO in the post-discharge. Such a method, called the air-afterglow technique, has been previously proposed in oxygen post-discharge [7,8]. It is

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Fig. 1. — Experimental set-up for N and O atoms titration by NO.

presently extended to Ar-O₂-H₂ gas mixtures by taking into account the possible influence of the different gases on this titration scheme.

2. The Experimental Set-Up

The same flowing microwave post-discharge reactor as described in references [5,6] has been presently experimented. It is reproduced in Figure 1. The 2 450 MHz microwave plasma is produced in a quartz tube of 0.5 cm diameter with a surfaguide at a transmitted power of 130 W, a flow rate of 500-1050 sccm and a gas pressure of 300-1 500 Pa. The post-discharge runs into a reactor tube of diameter 2.8 cm at a distance of 70 cm from the surfaguide, corresponding to a post-discharge time $\Delta t \sim 10^{-2}$ s. Titration by NO is performed at the end of the 0.5 cm diameter quartz tube (75 cm from the surfaguide), in a mixing zone with a lateral exit of the flowing post-discharge (Fig. 1). The emission spectrum of the discharge and of the afterglow was analysed by using a Jobin-Yvon HR 640 spectrometer with a 1200 grooves mm⁻¹ grating and a photodiode array detector (IRY/1024).

3. N-Atom Density in Ar-N₂ and Ar-N₂-H₂ Post-Discharges

The N-atom density has been previously determined by NO titration [5]. The following reactions occur:

at low NO flow rates and:

at high NO flow rates.

Fig. 2. — N-atom titration plot for an Ar-4% N₂ afterglow at $P = 300$ Pa, $Q = 520$ sccm and $W = 130$ W.

The colour change (extinction point) from the NO β (violet) to the NO $_2^*$ continuum (green) is produced as the two N and NO flow rates are equal in quantity. At this extinction point, all N-atom initially in the post-discharge have been converted into O-atom. The corresponding N-atom density $[N]_0$ can be written $[N]_0 = [O] = [NO]_{\text{ext}}$. By using an Ar-1.4% NO gas mixture, $[N]_0 = (7 \pm 0.4) \times 10^{13} \text{ cm}^{-3}$ has been obtained as reproduced in Figure 2 for an Ar-4% N₂ post-discharge at 300 Pa. The total gas flow rate was $Q = 520$ sccm and the 2 450 MHz microwave power was $W = 130$ W. At 1 500 Pa of an Ar-5% N₂ post-discharge ($Q = 1050$ sccm) at the same HF power, it has been determined $[N]_0 = (4.1 \pm 0.1) \times 10^{14} \text{ cm}^{-3}$. The $\frac{[N]}{[N_2]_i}$ density ratio (where $[N_2]_i$ denotes the density of N₂ with the discharge off), is 2.4% as for the experiment at 300 Pa. This relative density is calculated by assuming $T = 300$ K in the post-discharge.

The rate coefficients of reaction (a) - (d) are at $T = 300$ K: $k_a = 3.7 \times 10^{-11} \text{ cm}^3 \text{ s}^{-1}$ [9], $k_b^{\text{Ar}} = 0.8 \times k_b^{\text{N}_2}$ [10], $k_b^{\text{N}_2} = (2.4 - 3.1) \times 10^{-34} \text{ cm}^6 \text{ s}^{-1}$ [10, 11], $k_c^{\text{N}_2} = 5.8 \times 10^{-32} \text{ cm}^6 \text{ s}^{-1}$, $k_c^{\text{Ar}} = 3.7 \times 10^{-32} \text{ cm}^6 \text{ s}^{-1}$ and $k_d^{\text{H}_2} = 6 \times 10^{-32} \text{ cm}^6 \text{ s}^{-1}$ [12]. The radiative loss frequency of NO $_2^*$ is $\gamma_r = 2.5 \times 10^4 \text{ s}^{-1}$ [13] and the quenching rate coefficients are $k_d^{\text{Ar}} = 3.9 \times 10^{-11} \text{ cm}^3 \text{ s}^{-1}$, $k_d^{\text{N}_2} = 6 \times 10^{-11} \text{ cm}^3 \text{ s}^{-1}$ and $k_d^{\text{H}_2} = 7.3 \times 10^{-11} \text{ cm}^3 \text{ s}^{-1}$ [14].

In writing reactions (a) - (d), it has been neglected the effects of collisions on N₂ (X, v) and N₂ (A) metastable molecules. Such excited molecules could play an important part in the early afterglow by heating the remaining electrons by superelastic collisions [15] and by producing excitation transfers [16]. In the present condition of late afterglow, these processes have been neglected. However, the N₂(X, v) vibrational molecules are present with N-atom and can react with O-atom by:

The rate coefficient for reaction (e) is important for $v > 12$, $k_e(v > 12) = 10^{-11} \text{ cm}^3 \text{ s}^{-1}$ [17], but as reaction (e) is followed by reaction (a) to restore O-atom, it has no effect on the presented kinetic schemes.

After the extinction point (for $[\text{NO}] > [\text{NO}]_{\text{ext}}$), the NO_2^* density is linearly increasing with $[\text{NO}]$ as shown in Figure 2. Such a variation can be explained by the following kinetics relation:

$$[\text{NO}_2^*] = \frac{[\text{O}][\text{NO}][\text{M}]k_c^M}{\gamma_r + [\text{M}]k_d^M} \quad (1)$$

By writing equation (1), the following two bodies reaction:

with $k_f = 5.6 \times 10^{-17} \text{ cm}^3 \text{ s}^{-1}$ [18] has been neglected for gas pressure $P > 100 \text{ Pa}$, since $[\text{M}]k_c^M > 2 \times 10^{-16} \text{ cm}^3 \text{ s}^{-1}$ for $\text{M} = \text{Ar}$. The radiative frequency γ_r can be neglected in equation (1) for $P > 100 \text{ Pa}$ since $[\text{M}]k_d^M > 10^6 \text{ s}^{-1}$ for $\text{M} = \text{Ar}$. Then, for high dilution of N_2 and H_2 molecular gases into argon, the intensity $I(\text{NO}_2^*)$ of the air afterglow continuum can be described by equation (2) in an Ar- N_2 gas mixture and by equation (3) in an Ar- N_2 - H_2 gas mixture:

$$I(\text{NO}_2^*) = K(\lambda)[\text{O}][\text{NO}] = K(\lambda)[\text{N}]_0[\text{NO}] \quad (2)$$

$$I(\text{NO}_2^*) = K(\lambda)[\text{N}]_0^{\text{H}_2}[\text{NO}] \quad (3)$$

with

$$K(\lambda) = k(\lambda) \frac{\sum_{\text{M}} k_c^M [\text{M}]}{\sum_{\text{M}} k_d^M [\text{M}]} \approx \frac{k_c^{\text{Ar}}}{k_d^{\text{M}}} k(\lambda) = 9.5 \times 10^{-22} k(\lambda) \quad (4)$$

$k(\lambda)$ is a calibration factor depending on spectrometer spectral response, on photon energy and optical emission probability of NO_2^* and $[\text{N}]_0^{\text{H}_2}$ is the initial N-atom density in the Ar- N_2 - H_2 gas mixture. Note that chemiluminescence with O_3 has not been considered here since, first substantial O_3 density only appears at high O_2 gas pressure and second, the NO-O_3 continuum is extending from 600 to 2200 nm [18] at larger wavelengths that presently used for NO_2^* detection: $\lambda = 575 \text{ nm}$.

The results obtained with an Ar-3.8% N_2 -0.2% H_2 gas mixture at $P = 300 \text{ Pa}$, $Q = 521 \text{ sccm}$ and $W = 130 \text{ W}$ are reproduced in Figure 3. First, it is found a sensitive increase of N-atom density with $[\text{N}]_0^{\text{H}_2} = (2.3 \pm 0.1) \times 10^{14} \text{ cm}^{-3}$ which is 3.3 higher than without H_2 . The increase of N-atom density with a few H_2 into N_2 has been previously analysed by LIF in DC N_2 - H_2 flowing post-discharge [19]. Recently, an increase of about 3 of N-atom density has been found in an Ar-10% N_2 -0.5% H_2 microwave post-discharge [20]. This seems to be connected to an increase of the discharge electric field and to a reduction of N-atom recombination on the post-discharge tube as a few H_2 is introduced into N_2 .

The slope of the $I(\text{NO}_2^*)$ variations with NO as determined in Figures 2 and 3 are $r_1 = K(\lambda)[\text{N}]_0$ and $r_2 = K(\lambda)[\text{N}]_0^{\text{H}_2}$, respectively. With $r_1 = 5.3 \pm 0.9$, $[\text{N}]_0 = (7 \pm 0.4) \times 10^{13} \text{ cm}^{-3}$, $r_2 = 16 \pm 2$ and $[\text{N}]_0^{\text{H}_2} = (2.3 \pm 0.1) \times 10^{14} \text{ cm}^{-3}$, it follows that:

$$\frac{r_2}{r_1} = \frac{[\text{N}]_0^{\text{H}_2}}{[\text{N}]_0} \quad (5)$$

Fig. 3. — N-atom titration plot for an Ar-3.8% N₂-0.2% H₂ afterglow at $P = 300$ Pa, $Q = 521$ sccm and $W = 130$ W.

4. O-Atom Density in Ar-O₂ and in Ar-O₂-H₂ Post-Discharges

In Ar-O₂-H₂ post-discharge, the oxygen atoms coming from the discharge are reacting with NO to produce NO₂* by reaction (c). For high O₂ and H₂ molecular gases dilution into argon and by using the following rate coefficients in equation (4): $k_c^{O_2} = 5.6 \times 10^{-32} \text{ cm}^{-6} \text{ s}^{-1}$ [12] for reaction (c) and $k_d^{O_2} = 5.4 \times 10^{-11} \text{ cm}^3 \text{ s}^{-1}$ [14] for reaction (d), it can be deduced that:

$$I(\text{NO}_2^*) = K(\lambda)[O][\text{NO}] \quad (6)$$

Variation of NO₂* intensity *versus* NO measured at the same wavelength with the same optical arrangement as above is reproduced in Figure 4 for an Ar-3.8% O₂-0.2% H₂ post-discharge at $P = 300$ Pa, $Q = 521$ sccm and $W = 130$ W. At this low H₂ percentage, the contribution of possible H₂O formed in the post-discharge has been neglected. The slope of NO₂* intensity *versus* Ar-1.4% NO flow rate is $r_3 = K(\lambda)[O]$ and by comparing with Figure 2 and Figure 3, it follows:

$$[O] = \frac{r_3}{r_1} [N]_0 = \frac{r_3}{r_2} [N]_0^{\text{H}_2} \quad (7)$$

With $r_3 = 120 \pm 10$, $r_1 = 5.3 \pm 0.9$, $[N]_0 = (7 \pm 0.4) \times 10^{13} \text{ cm}^{-3}$, equation (6) gives $[O] = (1.6 \pm 0.5) \times 10^{15} \text{ cm}^{-3}$. It results that the density ratio $C_0 = \frac{[O]}{[O_2]_i}$ (where $[O_2]_i$ denotes the density of O₂ with the discharge off) in the actual Ar-3.8% O₂-0.2% H₂ flowing HF post-discharge at 300 Pa is as high as 0.6. This value is considerably higher than those obtained in pure oxygen microwave post-discharges which normally ranges around 0.01 and 0.1 [21–24] and could only be compared to C_0 obtained in microwave discharge in O₂ [25]. Such high O atom density is probably due to the high argon dilution used in the present experiments and to the use of hydrogen.

It has been previously found that small amounts of molecular gases (N₂, H₂) increase the extent of dissociation of O₂ molecules in electrical discharges [22, 23]. In a microwave post-discharge at 70 Pa, Brown [22] observed an increase in C_0 up to 0.5 when traces of impurities

Fig. 4. — O-atom titration plot for an Ar-3.8% O_2 -0.2% H_2 afterglow at $P = 300 \text{ Pa}$, $Q = 521 \text{ sccm}$ and $W = 130 \text{ W}$.

Fig. 5. — Relative O-atom density (C_0) versus hydrogen percentage ($y\%$) for an Ar-1.2% O_2 - $y\%$ H_2 microwave discharge at $P = 1\,500 \text{ Pa}$, $1\,039.5 \leq Q \leq 1\,049.5 \text{ sccm}$ and $W = 130 \text{ W}$.

such H_2O or H_2 were injected in the O_2 discharge. As it is reproduced in Figure 5 for the present experiment at $1\,500 \text{ Pa}$ ($1\,039.5 \leq Q \leq 1\,049.5 \text{ sccm}$), the oxygen atom density in the Ar-1.2% O_2 - $y\%$ H_2 post-discharge is decreasing from $[\text{O}] = (2.1 \pm 0.4) \times 10^{15} \text{ cm}^{-3}$, $C_0 = 0.48$ as $y(\text{H}_2) = 0$ to $(7 \pm 1) \times 10^{14} \text{ cm}^{-3}$, $C_0 = 0.16$ as $y(\text{H}_2) = 1\%$. This behaviour was also observed by increasing the pressure at constant mass flow rate and constant H_2 addition in O_2 [22]. The high initial C_0 value may be due to impurities such as water vapour adsorbed on the reactor

walls [28]. Moreover, the destruction of O atoms may be either by heterogeneous (surface recombination) or by homogeneous (gas phase) reactions. The decrease of O-atom density in introducing H₂ in the high pressure Ar-O₂ gas mixture could be explained by homogeneous reaction involving H atoms and OH radicals such as:

with $k_g = 4.3 \times 10^{-32} \text{ cm}^6 \text{ s}^{-1}$ [26] and $k_h = 2.9 \times 10^{-11} \text{ cm}^3 \text{ s}^{-1}$ [27].

5. Conclusion

The O-atom density determination by NO titration has been discussed from kinetic point of view for the complex post-discharge in Ar-O₂-H₂. Addition of small quantities of H₂ to Ar-N₂ mixture has been investigated for N-atom density determination and consequences on O-atom density determination is also discussed. It can be concluded that N-atom density is significantly enhanced by H₂ addition by a factor 3 in Ar-3.8% N₂-0.2% H₂ at 300 Pa ($Q = 520 \text{ sccm}$). Both Ar-N₂ and Ar-N₂-H₂ mixtures can serve as references for O atom titration by NO in Ar-O₂ or Ar-O₂-H₂ post-discharge. Relative O-atom densities as high than 0.5-0.6 has been determined in Ar-O₂ post-discharge at 300 Pa ($Q = 520 \text{ sccm}$) and 1 500 Pa ($Q = 1\,039.5 \text{ sccm}$). This is probably related to H₂O settled on the reactor walls that inhibits the surface recombination of O-atom. It has been found a sensitive decrease of O-atom density as H₂ is initially introduced in an Ar-O₂ gas mixture. Works are in progress to analyse the kinetics processes in Ar-O₂-H₂ gas flowing post-discharges.

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